

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination KOBAYASHI ET AL.	
		Examiner	Art Unit	Page 1 of 1
U.S. PATENT DOCUMENTS				

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,898,293	04-1999	Tamai et al.	320/136
*	B	US-5,929,603	07-1999	Nakao et al.	320/136
*	C	US-5,477,124	12-1995	Tamai, Mikitaka	320/135
*	D	US-4,803,417	02-1989	Nowakowski et al.	320/136
*	E	US-6,703,796	03-2004	Che-Chen et al.	315/291
*	F	US-6,242,893	06-2001	Freedman, Robert P.	320/135
*	G	US-5,164,653	11-1992	Reem, James B.	320/135
*	H	US-5,850,136	12-1998	Kaneko, Akira	320/119
*	I	US-5,585,994	12-1996	Tamai et al.	361/98
*	J	US-6,437,539	08-2002	Olsson et al.	320/118
*	K	US-5,856,738	01-1999	Yoshimatsu, Morio	320/136
*	L	US-5,883,495	03-1999	Smith et al.	320/128
*	M	US-6,377,024	04-2002	Choy, Winnie W.	320/118

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.